Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/786,622	INOUE ET AL.
Examiner	Art Unit
Mei Q. Huang	1713

	SEARCHED			
Class	Subclass	Date	Examiner	
524	4, 5, 8	6/16/2005	МQН	
524	388, 396	6/16/2005	мон	
524	127,	6/16/2005	MQH	
106	109, 823	6/16/2005	МОН	
		,		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
524	127	6/16/2005	мон	
			-	

SEARCH (INCLUDING SEAR	NOTES RCH STRATEGY	')
	DATE	EXMR
Inventor search	6/16/2005	МФН
EAST search attached	6/16/2005	МОН
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